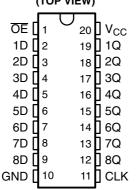
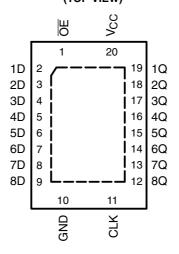
SCBS191F - JANUARY 1991 - REVISED SEPTEMBER 2003

- Typical V_{OLP} (Output Ground Bounce) <1 V at V_{CC} = 5 V, T_A = 25°C
- High-Drive Outputs (-32-mA I_{OH}, 64-mA I_{OL})
- Ioff Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 500 mA Per **JEDEC Standard JESD 17**
- **ESD Protection Exceeds JESD 22**
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)

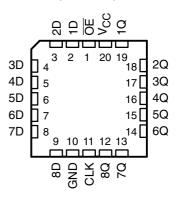
SN54ABT574...J OR W PACKAGE **SN74ABT574A...DB, DW, N, NS, OR PW PACKAGE** (TOP VIEW)



SN74ABT574A . . . RGY PACKAGE (TOP VIEW)



SN54ABT574 . . . FK PACKAGE (TOP VIEW)



description/ordering information

These 8-bit flip-flops feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

ORDERING INFORMATION

T _A	PACKAGE [†]	+	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – N	Tube	SN74ABT574AN	SN74ABT574AN
	QFN – RGY	Tape and reel	SN74ABT574ARGYR	AB574A
	COIC DW	Tube	SN74ABT574ADW	ADT574A
	SOIC - DW	Tape and reel	SN74ABT574ADWR	ABT574A
4000 to 0500	SOP - NS	Tape and reel	SN74ABT574ANSR	ABT574A
–40°C to 85°C	SSOP – DB	Tape and reel	SN74ABT574ADBR	AB574A
	TOCOD DW	Tube	SN74ABT574APW	AD574A
	TSSOP – PW	Tape and reel	SN74ABT574APWR	AB574A
	VFBGA – GQN	Ton a and week	SN74ABT574AGQNR	AD574A
	VFBGA – ZQN (Pb-free)	Tape and reel	SN74ABT574AZQNR	AB574A
	CDIP – J	Tube	SNJ54ABT574J	SNJ54ABT574J
-55°C to 125°C	CFP – W	Tube	SNJ54ABT574W	SNJ54ABT574W
	LCCC – FK	Tube	SNJ54ABT574FK	SNJ54ABT574FK

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



1

SCBS191F - JANUARY 1991 - REVISED SEPTEMBER 2003

description/ordering information (continued)

The eight flip-flops of the SN54ABT574 and SN74ABT574A are edge-triggered D-type flip-flops. On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

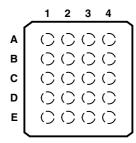
A buffered output-enable (OE) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

OE does not affect the internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

SN74ABT574A . . . GQN OR ZQN PACKAGE (TOP VIEW)



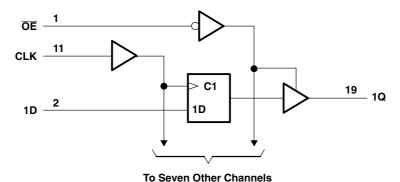
terminal assignments

	1	2	3	4
Α	1D	ŌĒ	V_{CC}	1Q
В	3D	3Q	2D	2Q
С	5D	4D	5Q	4Q
D	7D	7Q	6D	6Q
Ε	GND	8D	CLK	8Q

FUNCTION TABLE (each flip-flop)

	INPUTS		OUTPUT
OE	CLK	D	Q
L	↑	Н	Н
L	\uparrow	L	L
L	H or L	Χ	Q_0
Н	X	Χ	Z

logic diagram (positive logic)



Pin numbers shown are for the DB, DW, FK, J, N, NS, PW, RGY, and W packages.



SCBS191F - JANUARY 1991 - REVISED SEPTEMBER 2003

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	
Voltage range applied to any output in the high or power-off state, V _O	0.5 V to 5.5 V
Current into any output in the low state, I _O : SN54ABT574	96 mA
SN74ABT574A	128 mA
Input clamp current, I _{IK} (V _I < 0)	–18 mA
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Package thermal impedance, θ_{JA} (see Note 2): DB package	70°C/W
(see Note 2): DW package	58°C/W
(see Note 2): GQN/ZQN package	78°C/W
(see Note 2): N package	69°C/W
(see Note 2): NS package	60°C/W
(see Note 2): PW package	83°C/W
(see Note 3): RGY package	37°C/W
Storage temperature range, T _{stg}	\dots –65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

- 2. The package thermal impedance is calculated in accordance with JESD 51-7.
- 3. The package thermal impedance is calculated in accordance with JESD 51-5.

recommended operating conditions (see Note 4)

			SN54A	BT574	SN74AB	UNIT	
			MIN	MAX	MIN	MAX	UNII
V _{CC}	Supply voltage		4.5	5.5	4.5	5.5	V
V _{IH}	High-level input voltage		2		2		V
V _{IL}	Low-level input voltage			0.8		0.8	V
VI	Input voltage		0	V _{CC}	0	V_{CC}	V
I _{OH}	High-level output current			-24		-32	mA
I _{OL}	Low-level output current			48		64	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled		5		5	ns/V
T _A	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



SCBS191F - JANUARY 1991 - REVISED SEPTEMBER 2003

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		T	_A = 25°C	;	SN54A	BT574	SN74ABT574A				
PARAMETER		TEST CONDITIO	MIN	TYP†	MAX	MIN	MAX	MIN	MAX	UNIT	
V _{IK}	$V_{CC} = 4.5 \text{ V},$	$I_I = -18 \text{ mA}$				-1.2		-1.2		-1.2	V
	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -3 \text{ mA}$		2.5			2.5		2.5		
.,	$V_{CC} = 5 V$,	$I_{OH} = -3 \text{ mA}$		3			3		3		٧
V _{OH}	V 45V	$I_{OH} = -24 \text{ mA}$		2			2				V
	$V_{CC} = 4.5 \text{ V}$	$I_{OH} = -32 \text{ mA}$		2*					2		Ī
.,	V 45V	$I_{OL} = 48 \text{ mA}$				0.55		0.55			٧
V _{OL}	$V_{CC} = 4.5 \text{ V}$	$I_{OL} = 64 \text{ mA}$				0.55*				0.55	V
V_{hys}					100						mV
I _I	$V_{CC} = 5.5 \text{ V},$	$V_I = V_{CC}$ or GNI)			±1		±1		±1	μΑ
I _{OZH}	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$				10 [‡]		10 [‡]		10 [‡]	μΑ
l _{OZL}	$V_{CC} = 5.5 \text{ V},$	$V_{O} = 0.5 \text{ V}$				-10 [‡]		-10 [‡]		-10 [‡]	μΑ
I _{off}	$V_{CC} = 0$,	V_I or $V_O \le 4.5 \text{ V}$				±100		±500		±100	μΑ
I _{CEX}	$V_{CC} = 5.5 \text{ V},$	$V_{O} = 5.5 \text{ V}$	Outputs high			50		50		50	μΑ
I _O §	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.5 \text{ V}$		-50	-100	-180	-50	-180	-50	-180	mA
	.,	•	Outputs high		1	250		250		250	μΑ
Icc	$V_{CC} = 5.5 \text{ V}, I_{O}$ $V_{I} = V_{CC} \text{ or GN}$		Outputs low		24	30		30		30	mA
	V1 = VCC 01 G11	,,,	Outputs disabled		0.5	250		250		250	μΑ
Δlcc¶	V _{CC} = 5.5 V, O Other inputs at	ne input at 3.4 V, V _{CC} or GND				1.5		1.5		1.5	mA
C _i	$V_I = 2.5 \text{ V or } 0.$.5 V			3.5						pF
Co	$V_0 = 2.5 \text{ V or } 0$).5 V			6.5						pF

^{*} On products compliant to MIL-PRF-38535, this parameter does not apply.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

				SN54A	BT574		
			V _{CC} = T _A = 2	$V_{CC} = 5 V$, $T_A = 25^{\circ}C$		MAX	UNIT
			MIN	MAX			
f _{clock}	Clock frequency			150		150	MHz
t _w	Pulse duration, CLK high or low		3.3		3.3		ns
	Catura time and atach afore CLIVA	High	1.5		1.5		
t _{su}	Setup time, data before CLK↑	Low	2		2		ns
t _h	Hold time, data after CLK↑	High or low	2		2		ns



[†] All typical values are at $V_{CC} = 5 \text{ V}$.

[‡] This data-sheet limit may vary among suppliers.

[§] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

SCBS191F - JANUARY 1991 - REVISED SEPTEMBER 2003

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

				SN74A	3T574A		
			V _{CC} :	V _{CC} = 5 V, T _A = 25°C MIN MAX		UNIT	
			MIN	MAX		ļ	
f _{clock}	Clock frequency			150		150	MHz
t _w	Pulse duration, CLK high or low		3.3		3.3		ns
	Catua tima data hafaya CLIV	High	1		1		
t _{su}	Setup time, data before CLK↑	Low	1.5		1.5		ns
t _h	Hold time, data after CLK↑	High or low	1.8 [†]		1.8 [†]		ns

[†] This data-sheet limit may vary among suppliers.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50$ pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V ₀	_{CC} = 5 V _A = 25°C	,	MIN	MAX	UNIT
			MIN	TYP	MAX			
f _{max}			150	200		150		MHz
t _{PLH}	OLK	0	2.2	3.9	6.2	2.2	7	
t _{PHL}	CLK	Q	3	4.8	7	3	7.4	ns
t _{PZH}	OF.	•	1	3.3	5	1	5.8	
t _{PZL}	ŌĒ	Q	2.5	4.7	5.9	2.5	7.2	ns
t _{PHZ}	OF.	0	2.4	4.9	6.2	2.4	7.2	
t _{PLZ}	ŌĒ	Q	2	4	5.8	2	6.9	ns

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

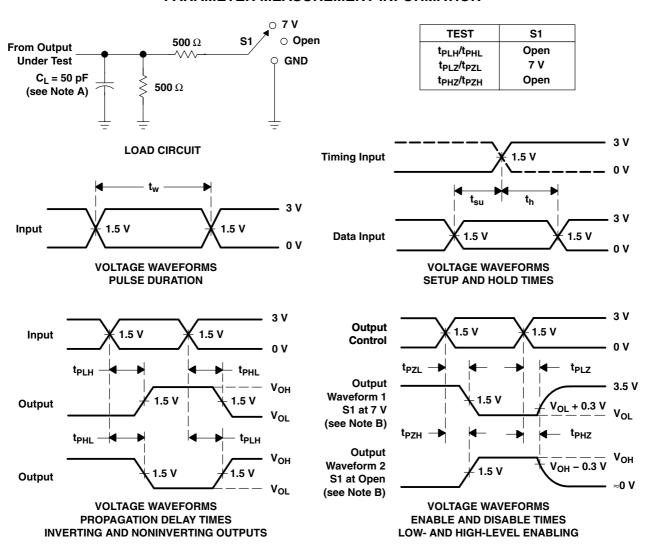
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V ₀	_{CC} = 5 V _A = 25°C	,	MIN	MAX	UNIT
			MIN	TYP	MAX			
f _{max}			150	200		150		MHz
t _{PLH}	OLIK	0	2.2	3.9	6.2	2.2	6.8	
t _{PHL}	CLK	Q	3	4.8	6.6	3	7.1	ns
t _{PZH}	oe	•	1	3.3	4.3	1	5.1	
t _{PZL}	ŌĒ	Q	2.1†	4.7	5.9	2.1†	6.7	ns
t _{PHZ}	OF.	_	2.4	4.9	6.2	2.4	7	
t _{PLZ}	ŌĒ	Q	2	4	5.8	2	6.5	ns

[†] This data-sheet limit may vary among suppliers.



SCBS191F - JANUARY 1991 - REVISED SEPTEMBER 2003

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{Q} = 50 Ω , $t_{r} \leq$ 2.5 ns, $t_{f} \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms







www.ti.com 2-Dec-2023

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9322001Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9322001Q2A SNJ54ABT 574FK	Samples
5962-9322001QRA	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9322001QR A SNJ54ABT574J	Samples
5962-9322001QSA	ACTIVE	CFP	W	20	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9322001QS A SNJ54ABT574W	Samples
SN74ABT574ADBR	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB574A	Samples
SN74ABT574ADW	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT574A	Samples
SN74ABT574ADWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT574A	Samples
SN74ABT574ADWRE4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT574A	Samples
SN74ABT574AN	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74ABT574AN	Samples
SN74ABT574ANE4	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74ABT574AN	Samples
SN74ABT574ANSR	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT574A	Samples
SN74ABT574APW	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB574A	Samples
SN74ABT574APWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB574A	Samples
SNJ54ABT574FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9322001Q2A SNJ54ABT 574FK	Samples
SNJ54ABT574J	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9322001QR A SNJ54ABT574J	Samples
SNJ54ABT574W	ACTIVE	CFP	W	20	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9322001QS A SNJ54ABT574W	Samples

PACKAGE OPTION ADDENDUM

www.ti.com 2-Dec-2023

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 5-Dec-2023

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

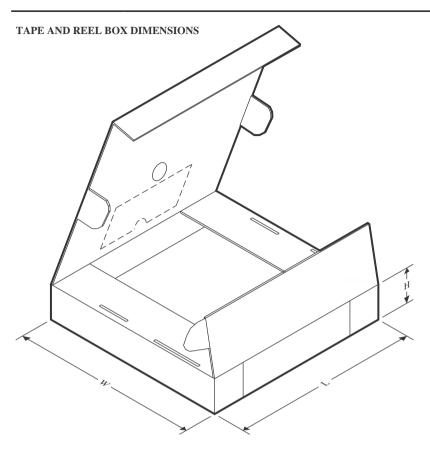
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ABT574ADBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74ABT574ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74ABT574ANSR	so	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74ABT574APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1

www.ti.com 5-Dec-2023



*All dimensions are nominal

7 til dillionorio di o mominar							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ABT574ADBR	SSOP	DB	20	2000	356.0	356.0	35.0
SN74ABT574ADWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74ABT574ANSR	SO	NS	20	2000	367.0	367.0	45.0
SN74ABT574APWR	TSSOP	PW	20	2000	356.0	356.0	35.0

PACKAGE MATERIALS INFORMATION

www.ti.com 5-Dec-2023

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9322001Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9322001QSA	W	CFP	20	25	506.98	26.16	6220	NA
SN74ABT574ADW	DW	SOIC	20	25	507	12.83	5080	6.6
SN74ABT574AN	N	PDIP	20	20	506	13.97	11230	4.32
SN74ABT574ANE4	N	PDIP	20	20	506	13.97	11230	4.32
SN74ABT574APW	PW	TSSOP	20	70	530	10.2	3600	3.5
SNJ54ABT574FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54ABT574W	W	CFP	20	25	506.98	26.16	6220	NA





- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.

 D. Index point is provided on cap for terminal identification only.

 E. Falls within Mil—Std 1835 GDFP2—F20







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2023, Texas Instruments Incorporated